

# Search Notes



Application/Control No.

10/719,617

Examiner

EDMUND H. LEE

Applicant(s)/Patent under  
Reexamination

HANNAN ET AL.

Art Unit

1732

## SEARCHED

Class	Subclass	Date	Examiner
upward		6/12/06	EA

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
upward	6/12/06	EA